

# BEST AVAILABLE COPY

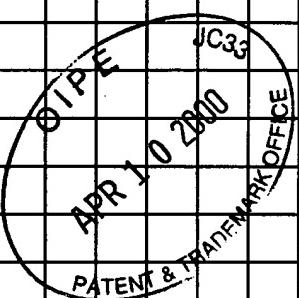
Sheet 1 of 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION <i>(Use several sheets if necessary)</i>								Docket No. (Optional) P01896US0		Application Number 09/418,902				
								Applicant: Walter V. Klemp, et al.						
								Filing Date: October 15, 1999		Group Art Unit 3735				
<b>U.S. PATENT DOCUMENTS</b>														
EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
MUC	6	0	5	6	7	3	2	05/02/2000	Fujioka et al.		604	385.1		
<b>FOREIGN PATENT DOCUMENT(S)</b>														
DOCUMENT NUMBER								DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION	
													YES	No
<b>OTHER DOCUMENTS</b> <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>														
												RECEIVED SEP 13 2000 TECHNOLOGY CENTER 3700		
EXAMINER								DATE CONSIDERED						
<i>Michele Kidwell</i>								12/31/00						

**EXAMINER:** Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

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Sheet 1 of 1

Form PTO-1449 <b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b> <i>(Use several sheets if necessary)</i>								Docket No. (Optional) P01896US0		Application Number 09/418,902			
								Applicant: Walter V. Klemp, et al.					
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<b>U.S. PATENT DOCUMENTS</b>													
EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MK	6	0	1	0	4	9	0	01/04/2000	Freeland et al.		604	385.1	
MK	6	0	1	7	3	3	6	01/25/2000	Sauer		604	385.1	
													
<b>FOREIGN PATENT DOCUMENT(S)</b>													
EXAMINER	DOCUMENT NUMBER							DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION TECHNOLOGY CENTER 3100
											YES	NO	RECEIVED APR 12 2000
<b>OTHER DOCUMENTS</b> (Including Author, Title, Date, Pertinent Pages, Etc.)													
EXAMINER								DATE CONSIDERED					
Michele Kidwell								12/3/00					
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Sheet 1 of 2

Sheet 1 of 2

Form PTO-1449

Docket No. (Optional)  
P01896US0

Application Number  
09/418,902

**INFORMATION DISCLOSURE CITATION  
IN AN APPLICATION**

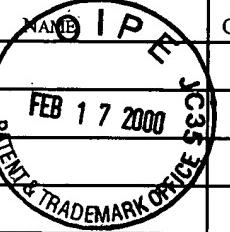
(Use several sheets if necessary)

Applicant:  
Klemp, Walter V., et al.

Filing Date:  
10/15/99

Group Art Unit  
3735

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME 	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MKC	4	6	6	2	8	7	7	05/05/87	Williams	604	385A	
MKC	4	7	3	8	6	7	7	04/19/88	Foreman	604	385R	
MKC	4	7	5	3	6	4	6	06/28/88	Enloe	604	385R	
MKC	4	8	1	6	0	2	5	03/28/89	Foreman	604	385R	
MKC	4	9	3	8	7	5	4	07/03/90	Mesek	604	385.2	
MKC	4	9	9	8	9	2	9	03/12/91	Björksund et al.	604	385.2	
MKC	5	0	1	9	0	6	6	05/28/91	Freeland et al.	604	385.2	
MKC	5	0	2	6	3	6	4	06/25/91	Robertson	604	385.1	
MKC	5	3	0	4	1	5	9	04/19/94	Tanji et al.	604	385.2	
MKC	5	3	9	7	3	1	8	03/14/95	Dreier	604	385.2	
MKC	5	4	1	5	6	4	9	05/16/95	Watanabe et al.	604	385.2	

**FOREIGN PATENT DOCUMENT(S)**

	DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
												YES	NO
MKC	2	4	3	6	4			12/16/87	Japan				X
	0	5	7	0	9	8	0						
MKC	A	1						05/21/93	EPO				X

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**


EXAMINER

Michelle Kidwell

DATE CONSIDERED

12/3/00

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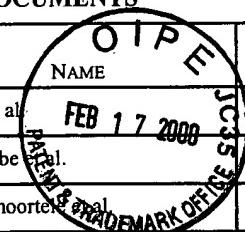
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Sheet 2 of 2

Form PTO-1449  <b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b> <i>(Use several sheets if necessary)</i>									Docket No. (Optional) P01896US0	Application Number 09/418,902			
Applicant: Klemp, Walter V., et al.									Filing Date: 10/15/99	Group Art Unit 3735			
<b>U.S. PATENT DOCUMENTS</b>													
EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
MJC	5	4	3	9	4	5	9	08/08/95	Tanji et al.	604	385.2		
MJC	5	4	4	9	3	5	3	09/12/95	Watanabe et al.	604	385.2		
MJC	5	5	6	9	2	2	7	10/29/96	Vandemoortele et al.	604	382		
MJC	5	6	7	2	1	6	6	09/30/97	Vandemoortele	604	385.2		
MJC	5	8	1	7	0	8	7	10/06/98	Takabayashi et al.	604	385.2		
MJC	5	8	2	7	2	5	9	10/27/98	Laux et al.	604	385.2		
MJC	5	9	3	1	8	2	6	08/03/99	Faulks et al.	604	385.2		
MJC	5	9	4	1	8	6	4	08/24/99	Roe	604	378		
<b>FOREIGN PATENT DOCUMENT(S)</b>													
	DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
												YES	NO
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>													
EXAMINER  <i>Michele Kidwell</i>									DATE CONSIDERED  <i>12/3/00</i>				
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